SRNT 3/22/05

Туре	L or K:.	Hits	Search Text	- DBs	: Time Stamp	Comments
BRS	L1	10319	((dark adj current) or (johnson adj noise) or (shot adj noise) or (thermal adj noise) or (kt adj noise) or (boltzmann adj noise))	USPAT	3/22/05 12:03	see below
IS&R	L2	583	(327/512).CCLS.	US-PGPUB; USPAT	3/22/05 12:01	see below
IS&R	L3	775	(327/513).CCLS.	US-PGPUB; USPAT	3/22/05 12:02	see below
BRS	L5	53	3 and (IMAG\$3 or VIDEO or camera or videosignal or videocamera)	USPAT	3/22/05 12:03	see below, note that this subclass is for temperature COMPENSATION, which is a reason to determine a temperature change
BRS	L6	6	1 and 2	USPAT	3/22/05 12:03	Browsed, directed toward COMPENSATION for thermal noise, Not using for Temperature measurement
BRS	. L7	2	1 and 3 not 2	USPAT	3/22/05 12:11	Browsed, directed toward COMPENSATION for thermal noise, Not using for Temperature measurement
BRS	L 4	25	2 and (IMAG\$3 or VIDEO or camera or videosignal or videocamera)	USPAT	3/22/05 12:14	LIST (US 3882384 A) measures Temperature using leakage current of transistor in combination with image sensing.
BRS	L8	44	5 not 2	US-PGPUB; USPAT	3/22/05 12:48	browsed.
BRS	L9	1.	("2794863" "3064193" "3157843" "3486821" "3523740").PN. OR ("3882384").URPN.	US-PGPUB; USPAT; USOCR	3/22/05 13:21	Janus Search using US 3882384 A (List; William F.) as kernel

000000000000000000000000000000000000000	aanaan aan aasagna	EMPERATURE SENSING IN AN IN VIV		444494555566666666666666666666666666666	
Туре	··· L or K:	Hits :: Search Text :: Search Text	DBs	Time Stamp	Comments
BRS	L1	("5886353" "5929689" "5953060" "6101287" "6 7 330345" "6418241" "4862237").PN.	US-PGPUB; USPAT	3/22/05 14:41	IDS in 10/290,397 - See East Comments
BRS	L2	("5008739" "5452001" "20030202111" "630392 3" "6607301" "5047863" "6144408" "4739495") 8 .PN.		3/22/05 15:21	892 in 10/290,397- See East Comments

ePHOENIX Reference Manager



	Y	PRESIDENCE R
Application Number	1	Submit
Application Number:	1	2007-001-002-001-002-002-002-002-002-002-002

Application Number 10/290,397

Testing 495769 - Form PTO-892, 13-JUN-2004, Paper Number 20050525

Document Number	Date	Inventor Names	Classification
US-5,008,739	04-1991	D'Luna et al.	348/246
US-5,452,001	09-1995	Hosier et al.	348/230.1
US-2003/0202111	10-2003	Park, Jaejin	348/243
US-6,303,923	10-2001	Wadsworth et al.	250/214LA
US-6,607,301	08-2003	Glukhovsky et al.	374/175
US-5,047,863	09-1991	Pape et al.	348/247
US-6,144,408	11-2000	MacLean, Steven D.	348/241
<u>US-4,739,495</u>	04-1988	Levine, Peter A.	348/247

EAST Search String:

("5008739"|"5452001"|"20030202111"|"6303923"|"6607301"|"5047863"|"6144408"|"4739495").PN.

	Comment
1	integrator or accumulator
2	offset control register
3	CMOS advantage sensors can be fabricated on a chip, lower cost> dark level is mentioned in Para. 4 ff Para. 8 => temperature variation, ETC.
4	dark level compensation circuit 130 dark pixel sensors 114; active pixel sensors 112
5	(Empty)
6	Black pattern correction for charge transfer sensor uses a reference dark frame (captured in absence of light)
7	invention here is to use a single dark frame, but use scaling factor for use with different integration times
8	(Empty)
9	(Empty)
10	Col. 4, Lines 24-29 dark current levels vary with temperature compensation stage 38 uses output of a temperature sensor 40 in thermal contact with imager 12

	Remove	Document ID	Image Document ID	Source	Page#
1		US 20030202111 A1	US 20030202111	US-PGPub Full	5
2		US 20030202111 A1	US 20030202111	US-PGPub Full	7
3		US 20030202111 A1	US 20030202111	US-PGPub Full	8
4		US 20030202111 A1	US 20030202111	US-PGPub Full	9
5		US 6607301 B1	US 6607301	US Full	1
6		US 6144408 A	US 6144408	US Full	1
7		US 6144408 A	US 6144408	US Full	2
8		US 6144408 A	US 6144408	US Full	7
9		US 5047863 A	US 5047863	US Full	1
10		US 4739495 A	US 4739495	US Full	6

ePHOENIX Reference Manager

SRNT 3/22/05

	······	8882800X.058888
Application Number:	j	Submit
Application Humber.	I	20000 100000000000000000

Application Number 10/290,397

Testing 269254 - Form PTO-1449, 21-FEB-2003, Paper Number 022103

Document Number	Date	Inventor Names	Classification
US-5,886,353	03-1999	Spivey et al.	250/370.09
US-5,929,689	07-1999	Wall, Llewellyn E.	327/362
<u>US-5,953,060</u>	09-1999	Dierickx, Bart	348/241
<u>US-6,101,287</u>	08-2000	Corum et al. DANK FRANCE Sub	382/274
US-6,330,345	12-2001	Russo et al.	382/115
<u>US-6,418,241</u>	07-2002	Schreiner, Horst	382/263
US-4,862,237	08-1989	Morozumi, Shinji	257/72

EAST Search String:

("5886353"|"5929689"|"5953060"|"6101287"|"6330345"|"6418241"|"4862237").PN.

	Comment
1	(Empty)
2	(Empty)
3	CMOS based camera systems have more noise (fixed pattern [caused by dark current/leakage currents]) than CCD-based systems Active Pixels have associated amplifier for each pixel.
4	(Empty)
5	MOS image sensor
6	amorphous silicon film has low dark current
7	cancels out dark current with dummy cell array and differential amplifier

<u> </u>	Remove	Document ID	Image Document ID	Source	Page#
1	<u> </u>	US 6101287 A	US 6101287	US Full	1
2		US 6101287 A	US 6101287	US Full	7
3		US 5953060 A	US 5953060	US Full	13
4		US 5929689 A	US 5929689	US Full	1
5		US 4862237 A	US 4862237	US Full	12
6		US 4862237 A	US 4862237	US Full	14
7		US 4862237 A	US 4862237	US Full	18

SRNT 3/22/05

Page 1 of 2 [User Document Collection: CITE IN 892 of MARCH 2005] Prection for dark current.

					7	**************************************
	Kemove	Document ID	Image Document ID	Source	Радеж	Commen
25		US 20040122315 A1 US 20040122315	US 20040122315	US-PGPub Full	-	medical capsule (ingestible includes camera, flashlamp, temperature sensor) US 20040122315 A1 (Krill, Jerry A.)
26		US 20040122315 A1 US 20040122315	US 20040122315	US-PGPub Full	7	an image sensor (Paragraph 26, an autonomous imaging device, an ingestible capsule including an optical camera) and determining a change in temperature in vivo (Paragraph 23, Lines 14-21). The image sensor is contained within an autonomous in vivo device (an ingestible/implantable capsule 10). The device disclosed by Krill further includes a controller, microprocessor 16 (Paragraph 22) for obtaining data samples from the image sensor. No teaching of obtaining a dark current data sample and accepting or receiving a dark current noise of the image sensor
27		US 20040122315 A1 US 20040122315	US 20040122315	US-PGPub Full	8	discloses auxiliary capsules may contain temperature sensors (e.g., in Paragraphs [0023] and [0032]) independent of the imaging camera.
28		US 20040122315 A1 US 20040122315	US 20040122315	US-PGPub Full	9	discloses introducing in vivo (Paragraph 15)
29		US 2768266 A	US 2768266	US Full	-	Thermal Noise thermometer == elements = resistor
9		US 2710899 A	US 2710899	US Full	-	RESISTOR UNIT FOR THERMAL NOISE THERMOMETER
31		US 20040099920 A1 US 20040099920	US 20040099920	US-PGPub Full	വ	ROSSI also a previously cited publication IMAGER circuitry
32		US 20040099920 A1 US 20040099920	US 20040099920	US-PGPub Full	9	Samples dark pixel, calibrates and calculates temperature
33		US 20040099920 A1 US 20040099920	US 20040099920	US-PGPub Full	-	Apparatus for determining temperature of an active pixel imager and correcting temperature induced variations in an imager
34		US 20040099920 A1 US 20040099920	US 20040099920	US-PGPub Full	2	Graph of Dark Current vs. Temperature
35		US 20020175269 A1 US 20020175269	US 20020175269	US-PGPub Full	-	Active Pixel Sensor KTC noise, temperature dependent (CMOS)
36		US 6614562 B1	US 6614562	US Full		ABSTRACT== Dark current noise may be compensated for in a digital imaging sensor by measuring the temperature of a silicon diode embedded on the same integrated circuit with the image sensor. This information may be used together with initial dark current calibration information, to provide dark current compensation on the fly during image capture. In some embodiments this may avoid the need for multiple shutter operations or repeatedly capturing a dark frame and then capturing a regular image frame.
37		US 6614562 B1	US 6614562	US Full	9	Col. 2 CMOS active pixel sensor
జ		US 6614562 B1	US 6614562	US Full	7	Cols. 3-4 == measure temperature using diode 410 as sensor